

AUTOMOTIVE GRADE

AUIRLS4030-7P

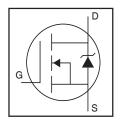
HEXFET® Power MOSFET

Features

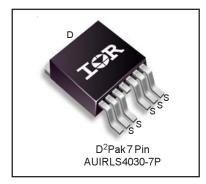
- · Optimized for Logic Level Drive
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V _{DSS}		100V
$R_{DS(on)}$	typ.	$\mathbf{3.2m}\Omega$
	max.	3.9m Ω
I _D		190A



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	190	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	130	А
I _{DM}	Pulsed Drain Current ①	750	
$P_{D} @ T_{C} = 25^{\circ}C$	Maximum Power Dissipation	370	W
	Linear Derating Factor	2.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally limited) ②	320	mJ
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	Α
E _{AR}	Repetitive Avalanche Energy ④		mJ
dv/dt	Peak Diode Recovery 3	13	V/ns
T _J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		
	Mounting torque, 6-32 or M3 screw	10lbf·in (1.1N·m)	

Avalanche Characteristics

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ® ®		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦ ®		40	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/



Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.10		V/°C	Reference to 25°C, I _D = 5mA ^①
R _{DS(on)}	Static Drain-to-Source On-Resistance		3.2	3.9	mΩ	$V_{GS} = 10V, I_D = 110A \oplus$
			3.3	4.1		$V_{GS} = 4.5V, I_D = 94A \oplus$
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Transconductance	250			S	$V_{DS} = 25V, I_{D} = 110A$
I _{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 100V, V_{GS} = 0V$
				250		$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 16V
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -16V$
R _{G(int)}	Internal Gate Resistance		2.0		Ω	

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

•	,							
	Parameter	Min.	Тур.	Max.	Units	Conditions		
Q_g	Total Gate Charge		93	140	nC	I _D = 110A		
Q_{gs}	Gate-to-Source Charge		27			$V_{DS} = 50V$		
Q_{gd}	Gate-to-Drain ("Miller") Charge		43			V _{GS} = 4.5V ④		
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})		50			$I_D = 110A, V_{DS} = 0V, V_{GS} = 4.5V$		
t _{d(on)}	Turn-On Delay Time		53		ns	$V_{DD} = 65V$		
t _r	Rise Time		160			I _D = 110A		
t _{d(off)}	Turn-Off Delay Time		110			$R_G = 2.7\Omega$		
t _f	Fall Time		87			V _{GS} = 4.5V ④		
C _{iss}	Input Capacitance		11490			$V_{GS} = 0V$		
C _{oss}	Output Capacitance		680			$V_{DS} = 50V$		
C _{rss}	Reverse Transfer Capacitance		300		pF	f = 1.0MHz		
C _{oss} eff. (ER)	Effective Output Capacitance (Energy Related)		760			$V_{GS} = 0V$, $V_{DS} = 0V$ to $80V$ ©		
C _{oss} eff. (TR)	Effective Output Capacitance (Time Related)		1170			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $		

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current			190	Α	MOSFET symbol
	(Body Diode)					showing the
I _{SM}	Pulsed Source Current			750		integral reverse
	(Body Diode) ①					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 110A, V_{GS} = 0V $
t _{rr}	Reverse Recovery Time		53		ns	$T_J = 25^{\circ}C$ $V_R = 85V$,
			63			$T_{\rm J} = 125^{\circ}{\rm C}$ $I_{\rm F} = 110{\rm A}$
Q_{rr}	Reverse Recovery Charge		99		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ μ s @
			155			$T_J = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		3.3		Α	$T_J = 25^{\circ}C$
t _{on}	Forward Turn-On Time	Intrins	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 0.05mH R_G = 25 Ω , I_{AS} = 110A, V_{GS} =10V. Part not recommended for use above this value .
- $\label{eq:local_local_local} \ensuremath{\Im} \ I_{SD} \leq 110 A, \ di/dt \leq 1520 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ} C.$
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.

- $\ ^{\circ}$ C $_{oss}$ eff. (TR) is a fixed capacitance that gives the same charging time as C $_{oss}$ while V $_{DS}$ is rising from 0 to 80% V $_{DSS}.$
- $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \ \,$ $\ \$ $\$ $\ \$ $\ \$ $\$
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ \ \, \mathbb{8} \,\, \mathsf{R}_{\theta} \, \mathsf{is} \,\, \mathsf{measured} \,\, \mathsf{at} \,\, \mathsf{T}_{\mathsf{J}} \, \mathsf{approximately} \,\, \mathsf{90^{\circ}C} \,.$

Qualification Information[†]

dualification Level		Automotive (per AEC-Q101) ††				
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		7L-D2 PAK MSL1				
	Machine Model	Class M4(+/- 800V) ^{†††}				
	Wacrime Woder	(per AEC-Q101-002)				
FCD	Human Rady Madal	Class H3A(+/- 6000V) ^{†††}				
ESD	Human Body Model	(per AEC-Q101-001)				
	Charried Daviss Madel	Class C5(+/- 2000V) ^{†††}				
	Charged Device Model	(per AEC-Q101-005)				
RoHS Compliant		Yes				

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.
- ††† Highest passing voltage

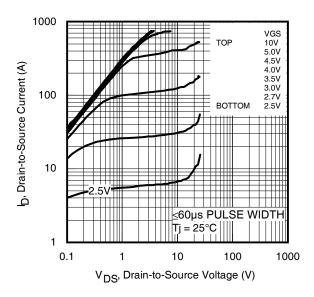


Fig 1. Typical Output Characteristics

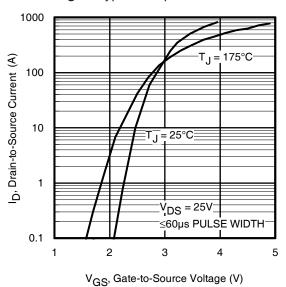


Fig 3. Typical Transfer Characteristics

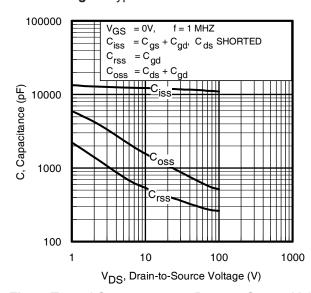


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

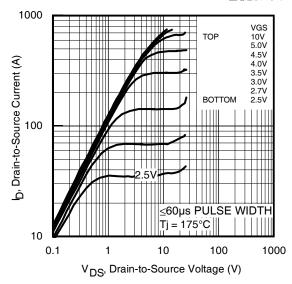


Fig 2. Typical Output Characteristics

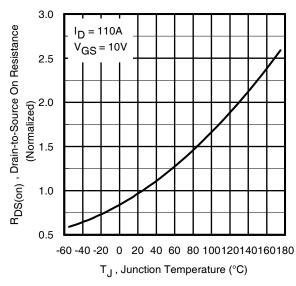


Fig 4. Normalized On-Resistance vs. Temperature

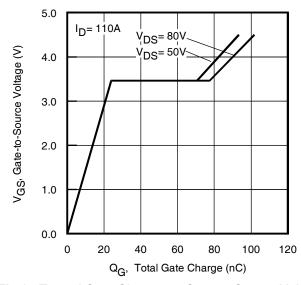


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com

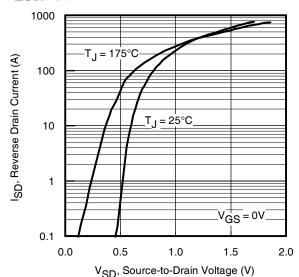


Fig 7. Typical Source-Drain Diode Forward Voltage

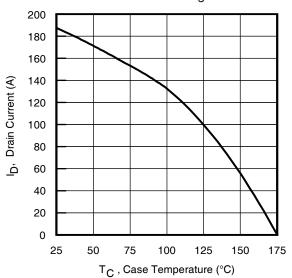
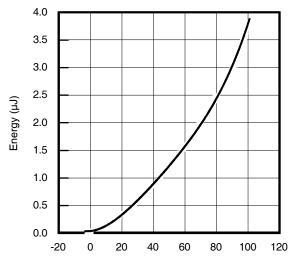


Fig 9. Maximum Drain Current vs. Case Temperature



V_{DS,} Drain-to-Source Voltage (V) **Fig 11.** Typical C_{OSS} Stored Energy

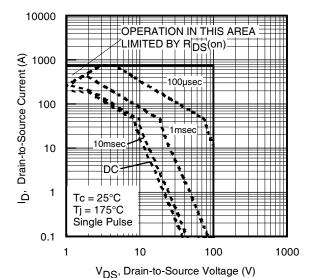


Fig 8. Maximum Safe Operating Area

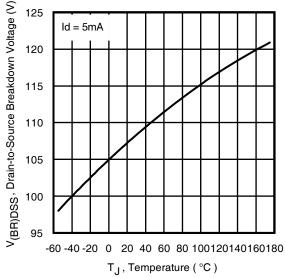


Fig 10. Drain-to-Source Breakdown Voltage

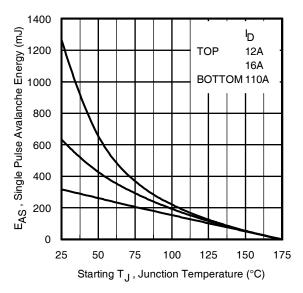


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

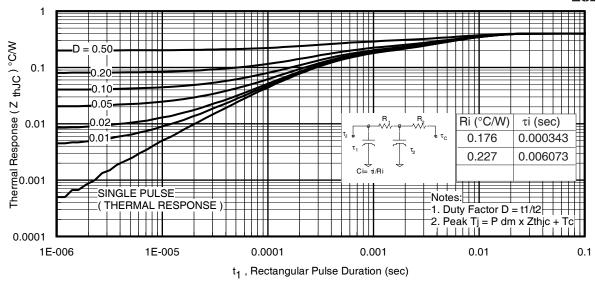


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

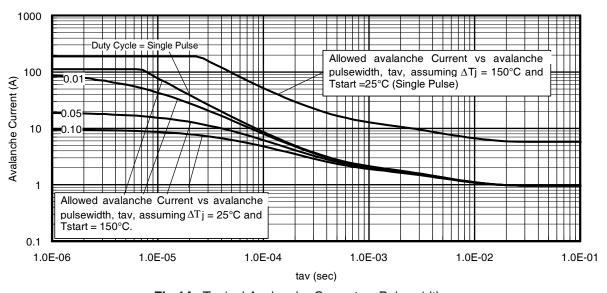


Fig 14. Typical Avalanche Current vs. Pulsewidth

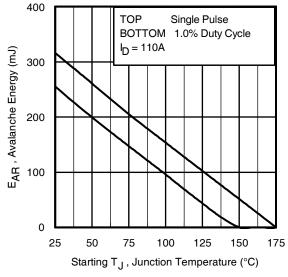


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

t_{av =} Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T / \; Z_{thJC} \\ I_{av} &= 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

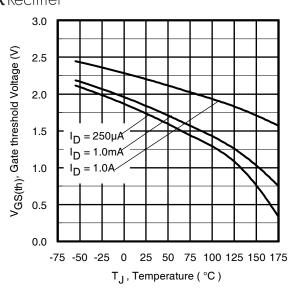


Fig 16. Threshold Voltage vs. Temperature

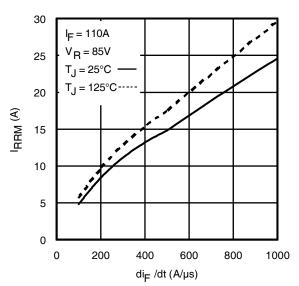


Fig. 18 - Typical Recovery Current vs. dif/dt

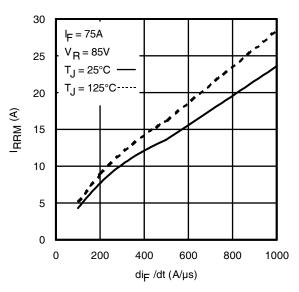


Fig. 17 - Typical Recovery Current vs. di_f/dt

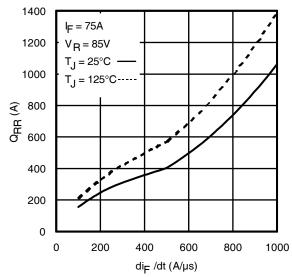


Fig. 19 - Typical Stored Charge vs. dif/dt

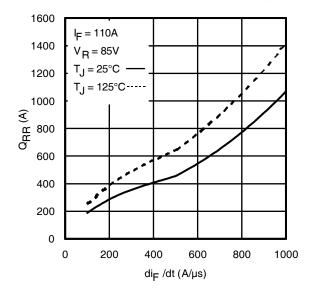
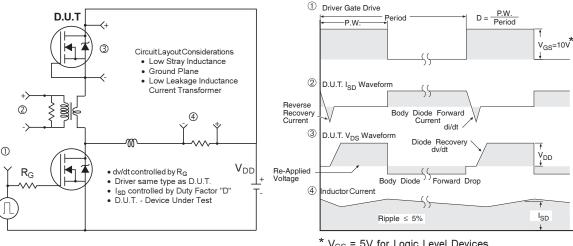


Fig. 20 - Typical Stored Charge vs. dif/dt



* V_{GS} = 5V for Logic Level Devices

Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

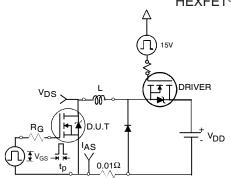


Fig 22a. Unclamped Inductive Test Circuit

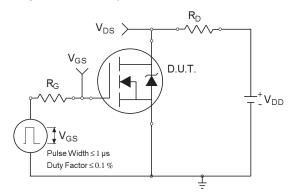


Fig 23a. Switching Time Test Circuit

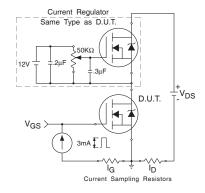


Fig 24a. Gate Charge Test Circuit

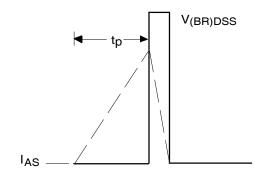


Fig 22b. Unclamped Inductive Waveforms

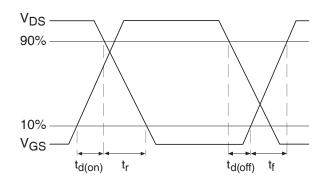


Fig 23b. Switching Time Waveforms

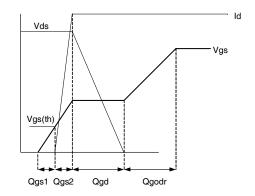
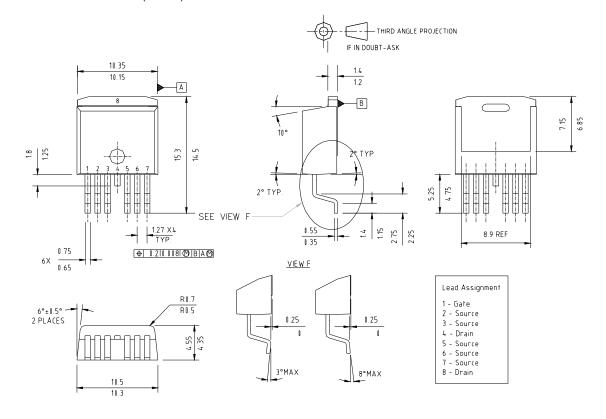


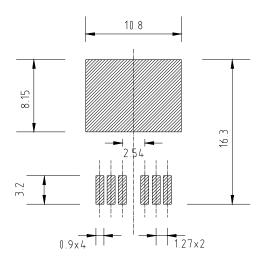
Fig 24b. Gate Charge Waveform

D²Pak - 7 Pin Package Outline

Dimensions are shown in millimeters (inches)

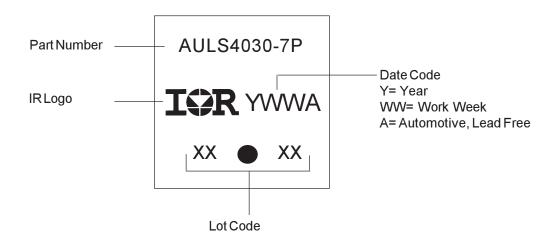


RECOMMENDED FOOTPRINT



REV	DATE	MODIFICATION
-	18/03/03	RAISED IAW ECN 3426
Rev1	07/04/03	CHANGED IAW ECN 3438
А	23/04/04	ADD LEAD ASSIGNMENT

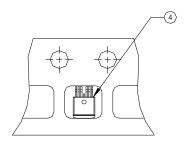
D²Pak - 7 Pin Part Marking Information



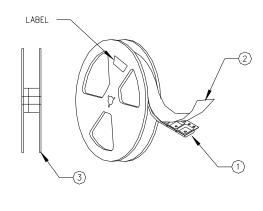
D²Pak - 7 Pin Tape and Reel

NOTES, TAPE & REEL, LABELLING:

- 1. TAPE AND REEL.
 - 1.1 REEL SIZE 13 INCH DIAMETER,
 - 1.2 EACH REEL CONTAINING 800 DEVICES.
 - 1.3 THERE SHALL BE A MINIMUM OF 42 SEALED POCKETS CONTAINED IN THE LEADER AND A MINIMUM OF 15 SEALED POCKETS IN THE TRAILER.
 - 1.4 PEEL STRENGTH MUST CONFORM TO THE SPEC. NO. 71-9667.
 - 1.5 PART ORIENTATION SHALL BE AS SHOWN BELOW.
 - 1.6 REEL MAY CONTAIN A MAXIMUM OF TWO UNIQUE LOT CODE/DATE CODE COMBINATIONS.
 REWORKED REELS MAY CONTAIN A MAXIMUM OF THREE UNIQUE LOT CODE/DATE CODE COMBINATIONS.
 HOWEVER, THE LOT CODES AND DATE CODES WITH THEIR RESPECTIVE QUANTITIES SHALL APPEAR ON THE BAR CODE LABEL FOR THE AFFECTED REEL.



- 2. LABELLING (REEL AND SHIPPING BAG).
 - 2.1 CUST. PART NUMBER (BAR CODE): IRFXXXXSTRL-7P
 - 2.2 CUST. PART NUMBER (TEXT CODE): IRFXXXXSTRL-7P
 - 2.3 I.R. PART NUMBER: IRFXXXXSTRL-7P
 - 2.4 QUANTITY:
 - 2.5 VENDOR CODE: IR
 - 2.6 LOT CODE:
 - 2.7 DATE CODE:



Ordering Information

Base part number	Package Type	Standard Pack	Complete Part Number	
		Form	Quantity	
AUIRLS4030-7P	D2Pak 7 Pin	Tube	50	AUIRLS4030-7P
		Tape and Reel Left	800	AUIRLS4030-7TRL
		Tape and Reel Right	800	AUIRLS4030-7TRR

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For technical support, please contact IR's Technical Assistance Center

http://www.irf.com/technical-info/

WORLDHEADQUARTERS:

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